

[illegible]

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SHEET 1 OF 1

LIST OF ART CITED BY APPLICANT
(PTO-1449)ATTY. DOCKET NO.
P-0592APPLN. SERIAL NO.
10/715,421

APPLICANT(S)

Sung-Kyung JANG

FILING DATE
November 19, 2003GROUP
2681**U.S. PATENT DOCUMENTS**

EXAMINER'S INITIALS	*PATENT NO.	*ISSUE DATE	*INVENTOR NAME	CLASS	SUBCLASS	FILING DATE

U.S. PATENT APPLICATION PUBLICATIONS

	*PATENT APPLN. PUB. NO.	*PUB. DATE	*APPLICANT	CLASS	SUBCLASS	

U.S. PATENT APPLICATIONS

	*APPLN. NO.	*FILING DATE	*INVENTOR	CLASS	SUBCLASS	

FOREIGN PATENT DOCUMENTS

EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
						Yes	No
rd	2002-204257	7/19/2002	JAPAN (Full Japanese Text)			Abst. only	
rd	2000-201383	7/18/2000	JAPAN (Full Japanese Text)			Abst. only	
rd	WO02/51101	6/27/2002	WIPO (Full Japanese Text)			Abst. only	
rd	WO02/065675	8/22/2002	WIPO			XX	

OTHER ART (Including Author, Title, Date, Pertinent Pages, Publisher, Place of Publication, Etc.)

rd	Japanese Office Action Dated December 1, 2005
EXAMINER	DATE CONSIDERED 02/01/07

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	*PATENT APPLN. PUB. NO.	*PUB. DATE	*APPLICANT	CLASS	SUBCLASS	
<i>ad</i>	2003/0007517	01/09/2003	BECKMANN et al.			
<i>ad</i>	2002/137521	09/26/2002	KIM et al.			
<i>ad</i>	2002/0097695	07/25/2002	HERMANN			

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EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
						Yes	No
<i>ad</i>	WO 02/091633	11/14/2002	PCT			X	
<i>ad</i>	DE 101 07 700 A1	08/29/2002	Germany (2003/007517 - U.S. equivalent))			X	

OTHER ART (Including Author, Title, Date, Pertinent Pages, Publisher, Place of Publication, Etc.)

<i>ad</i>	European Search Report dated September 5, 2006

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DATE CONSIDERED

02/01/07

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